Jitter and Eye-diagram Analysis Solution

DPOJET datasheet

DPOJET is the premier eye-diagram, jitter, and timing analysis package available for real-time oscilloscopes. DPOJET provides the highest sensitivity and accuracy available in real-time instruments. With comprehensive jitter and eye-diagram analysis and decomposition algorithms DPOJET simplifies discovering signal integrity concerns and jitter and their related sources in today’s high-speed serial, digital, and communication system designs.

Key features DPOJET Advanced

- Jitter and Timing Analysis for analog and digital clocks and data signals
- Real-time Eye-diagram (RT-Eye®) Analysis
- Selectable high- and low-pass measurement filters
- Ten plot types to view and analyze jitter: Eye Diagram, CDF Bathtub, Spectrum, Histogram, Composite Histogram, Trend, Data, Phase Noise, and Transfer Function
- Accurate jitter analysis using the spectral and Q-scale methods for detailed decomposition of jitter components, including the extraction of industry standard dual-dirac model parameters
- Jitter separation algorithms accurately measure the effects of bounded uncorrelated jitter (BUJ) which enables precise TJ measurements

Key features DPOJET Essentials-Advanced

- Period, frequency, and time interval error analysis
- Timing parametrics such as rise/fall times, pulse width, and duty cycle
- Many graphical tools such as Histograms, Time Trends, and Spectrums
- Programmable software clock recovery including software PLL
- User-selectable golden PLL support for popular standards
- Automatic bit rate and pattern length detection eases measurement configuration
- Selectable high- and low-limit measurement bounds test
- Comprehensive statistics logging, reporting, and remote automation
- Capture and save worst-case signals for detailed analysis
- TekWizard™ interface for one-button and guided jitter summaries

DPOJET Essentials is standard on all DPO/DSA/MSO70000, DPO7000, and MSO/DPO5000 Series oscilloscopes

Applications

- Characterize performance of high-speed serial and parallel bus designs
- Characterize clock and data jitter and signal integrity
- Characterize PLL dynamic performance
- Characterize modulation of spread spectrum clock circuits
- Characterize jitter generation, transfer, and tolerance
- Perform PHY testing of PCI Express, Serial ATA, SAS, Fibre Channel, MIPI® D-PHY, MIPI® M-PHY, DisplayPort, Thunderbolt, MHL, DDR, DDR2, DDR3, LPDDR, LPDDR2, SD UHS-II, MOST50, MOST150, USB 3.0, 10GBASE-KR/KR4, SFF-8431 SFP+ / 10GSFP+ Direct Attach Cable, and other electrical and optical systems

1 Patented USPTO #6,836,738

2 Patented USPTO #6,812,688.
Realtime jitter and eye-diagram analysis

DPOJET is the premiere eye-diagram, jitter, and timing analysis package available for real-time oscilloscopes. Operating in the Tektronix DPO/DSA/MSO70000, DPO7000, and MSO/DPO5000 Series oscilloscopes, DPOJET provides engineers the highest sensitivity and accuracy available in real-time instruments. With comprehensive jitter and eye-diagram analysis and decomposition algorithms DPOJET simplifies discovering signal integrity concerns and jitter and their related sources in today's high-speed serial, digital, and communication system designs.

Analog and digital designers in the computer, semiconductor, and communications industries are facing new challenges as processor clock speeds race beyond 3 GHz and back-plane bus and serial link data rates exceed 8 GT/s. These increasing speeds mean reduced circuit tolerance, or margin, for jitter and related signal integrity problems. By using tools that help you rapidly characterize and discover sources of jitter and signal integrity concerns, you can bring new designs to market faster, with more confidence that they operate reliably in today’s ultra high-speed environment.

Partial list of measurements

<table>
<thead>
<tr>
<th>Measurement</th>
<th>DPOJET Essentials</th>
<th>DPOJET Advanced</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Period/Frequency Measurements</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>Time Measurements</strong></td>
<td></td>
<td></td>
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<tr>
<td>Rise Time, Fall Time, Skew, High Time, Low Time, Setup, Hold, SSC Profile, SSC Modulation Rate, SSC Frequency Deviation, SSC Frequency Deviation Min, SSC Frequency Deviation Max, Time Outside Level, tCMD-CMD</td>
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<tr>
<td>Rise Slew Rate, Fall Slew Rate</td>
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<tr>
<td><strong>Amplitude Measurements</strong></td>
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<td>High, Low, High-Low, AC Common Mode, DC Common Mode, Overshoot, Undershoot, Cycle Min, Cycle Max, Cycle Pk-Pk, Common Mode, T/nT Ratio, Differential Crossover</td>
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<td><strong>Jitter Measurements</strong></td>
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<td>TIE, Phase Noise</td>
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<td>X</td>
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<tr>
<td>RJ, DJ, TJ @ BER, PJ, Clock NPJ, DCD, DDJ, RJ(Δ-Δ), DJ(Δ-Δ), J9, J9, Subrate, F/2, F/4, F/8</td>
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<td></td>
</tr>
<tr>
<td><strong>Eye-diagram Measurements</strong></td>
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<tr>
<td>Eye Height, Eye Height @ BER, Eye Width, Eye Width @ BER, Eye High, Eye Low, Q-Factor, Mask Hits, Autooff Mask Hits</td>
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<td>X</td>
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<tr>
<td><strong>Clock Recovery Methods</strong></td>
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3 Available on MSO digital channels

![Figure 1 – DPOJET Jitter Separation selection for legacy or BUJ model](image)

DPOJET Jitter and Eye-diagram Analysis Tools extend the capability of Tektronix real-time oscilloscopes, performing complex measurements and analysis of clock, serial, and parallel data signals captured in Single-shot Acquisition mode or in Continuous-run Acquisition mode. Measurements in DPOJET are supported on either analog or digital channels as shown in the measurement table above. Providing jitter and timing measurements with pass/fail parameter testing, and eye diagrams with mask testing for today’s most common industry standards, DPOJET is specifically designed to meet the advanced measurement needs of today’s high-speed digital designers in the computer and communications industries.

As data rates increase, next generation interfaces present new test and measurement challenges, including the need to measure and isolate sources of BUJ (for example crosstalk). Crosstalk can be caused due to the coupling of energy on the lane under test from adjacent lanes.
While Receiver and Transmitter Equalization can compensate for data dependent jitter (DDJ), crosstalk effects are difficult to remove. This has resulted in many standards, for example Thunderbolt, including BUJ in the jitter budget making BUJ a required measurement.

DPOJET provides support for both legacy and BUJ jitter separation algorithms as shown in Figure 1. When using the BUJ Jitter Decomposition method, the Clock NPJ measurement is available in the Jitter tab within DPOJET.

**Debug, Characterization, and Compliance**

DPOJET is the only Jitter and Eye Analysis software that enables multi-source analysis with configuration flexibility on a measurement by measurement basis providing the ultimate debug, characterization, and compliance environment.

**Multi-Lane Analysis**

With other jitter and eye analysis software solutions, analyzing multiple lanes is a painstaking process requiring multiple acquisitions to analyze each lane individually. DPOJET provides the capability to perform multiple measurements simultaneously on multiple sources, for example Ch1, Ch2, Ch3, and Ch4 enabling multi-lane analysis. Multiple lanes of traffic can be measured simultaneously allowing faster analysis and easy comparison of results for multi-lane standards including PCI Express, HDMI, and DisplayPort. This makes it easy to do visual comparison between the lanes and quickly note differences in signal quality parameters, for example noise, jitter, rise time, fall time, and amplitude between the lanes. Also available is DPOJET Reports which allows the generation of a html report which contains instrument and measurement configuration details, measurement results, and plots.

**Multi-Source Analysis**

Building upon the ability to perform the same measurement simultaneously multiple times, DPOJET provides an environment that is well suited for analyzing the effects of post-processing actions, for example de-embedding, embedding, and equalization. Together with SDLA Visualizer, DPOJET provides the analysis environment which allows simultaneous measurements on the signal and different test points within the link. For example, a comparison between the acquired waveform and the waveform after de-embedding can be quickly done providing the details needed to validate the effects of de-embedding on the acquired signal.

**Multi-Measurement Configuration**

Most high speed serial standards specify a reference phased locked loop (PLL) to use for clock recovery. This ensures that during the testing process that devices are all tested to the same standard. These PLLs are defined to filter or track the effects of low frequency jitter such as jitter due to Spread Spectrum Clocking (SSC). When using a PLL configuration that can track SSC, the SSC is attenuated and the result is a more open eye diagram. Typically, a 2nd order PLL is used to track the effects of SSC due to the ability to attenuate low frequency jitter. In cases where it is desired to see the effects of SSC constant clock recovery can be used which will not track the effects of SSC. Oftentimes, it is desired to see the effects of jitter, like SSC while at the same time evaluating the eye after using the reference PLL. This can quickly be done using the flexible measurement configuration feature in DPOJET. Measurements can be configured to all use the same clock recovery technique or individual measurements can be configured using different clock recovery methods.
Analysis of a USB 3 signal showing the differences between using a Type II PLL (left side) to attenuate low frequency jitter and Constant Clock Recovery (right side).

In other cases, it is desired to see the results in the frequency domain. DPOJET provides a spectral plot which shows the spectral content of the signal after clock recovery. The spectral content of the signal can quickly be compared after applying a 2nd order pll versus using constant clock recovery as shown in the image above.

Data Visualization

DPOJET supports displaying measurement results and plots on the internal display, on an external monitor, or both locations, thus making full use of the oscilloscope dual display ports.

DPOJET provides a rich set of interactive plots that enable analysis beyond what is possible with static plot images. Interactive features include zoom, pan, cursors, and finding the min and max values. For example, when looking at the spectral plot it is easy to find the frequency with the highest amplitude by using the Max cursor feature. The plot readout will then show the frequency and the amplitude of jitter.

DPOJET analysis plots, like Spectrum and Trend, go beyond simple measurements and results display. Trend analysis quickly shows engineers how timing parameters change over time, like frequency drift, PLL startup transients, or a circuit’s response to power supply changes. Spectrum analysis quickly shows the precise frequency and amplitude of jitter and modulation sources for easy, rapid identification. Finding sources like adjacent oscillators and clocks, power supply noise, or signal crosstalk is no longer a tedious chore. Unique in the industry, DPOJET also provides Phase Noise plots to show jitter in root/Hertz and Transfer Function plots that allow direct comparison of jitter spectrums between two signals of differing frequencies, providing the perfect tool for determining jitter in PLL circuits like clock multipliers. The composite histogram plot shows further details into the jitter components and their distribution in the data set.

Once all measurements are completed, the user has the flexibility to generate a test report which includes the instrument configuration, probe configuration, measurement results with pass fail status, measurement configuration details, and any plots that were generated. Alternatively, the user also has the flexibility to generate a .csv file that contains the results.
Ordering information

Model
DPOJET Advanced

Options
- Opt. DJA: Order preinstalled on a new oscilloscope

Upgrades
Order an upgrade for existing oscilloscope:
- DPO-UP Opt. DJAE: MSO/DPO5000 Series
- DPO-UP Opt. DJAM: DPO7000 Series
- DPO-UP Opt. DJAH: DPO/MSO70000 Series, 4-8 GHz
- DPO-UP Opt. DJAU: DPO/MSO70000 Series, >12 GHz
- DPOFL-DJA: Floating License

Physical characteristics
Software is supplied on internal hard disk and on compact disk media, or can be downloaded from www.tektronix.com. Software installs and operates with DPO/DSA/ MSO70000, DPO7000, or MSO/DPO5000 Series oscilloscopes. Online documentation and printable manual in PDF format are supplied with the product.

Recommended accessories
- Opt. DDRA: DDR Memory Bus Analysis
- Opt. eDP: Embedded DisplayPort Essentials
- Opt. FC-16G: Fibrechannel Essentials
- Opt. MOST: MOST Essentials Electrical Compliance and Debug Test Solution for MOST50
- Opt. PCE: PCI Express® Measurements for DPOJET
- Opt. PCE3: PCI Express Gen 3 (includes opt. PCE) Measurements for DPOJET
- Opt. SAS3: SAS Essentials
- Opt. SFP-TX: Ethernet SFP+ Compliance and Debug Solution
- Opt. SSP: SuperSpeed Plus Essentials
- Opt. UHS2: SDA UHS-II DPOJET Essentials
Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.